TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC94A29FAG, TC94A29FB

Single-Chip CD Processor with Built-in Controller (CD-CX)

The TC94A29FAG/FB is a single-chip CD processor for digital servo, which incorporates a 4-bit microcontroller.

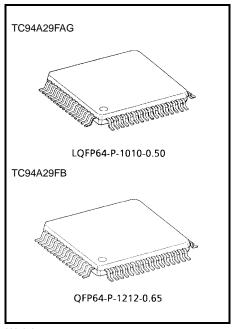
The controller features an LCD driver, 4-channel 6-bit AD converter, 1 port 2-channel 2/3-line or UART serial interface module, a buzzer, 20-bit general-purpose counter function, interrupt function, and 8-bit timer/counter. The CPU can select one of four operating clocks (16.9344-MHz, 75-kHz or 32.768-kHz crystal oscillator and CR oscillator), facilitating interface with the CD processor.

The CD processor incorporates sync separation protection and interpolation, EFM demodulator, error correction, digital equalizer for servo, and servo controller. The CD processor also incorporates a 1-bit DA converter. In combination with the TA2157F/FN digital servo head amplifier, the TC94A29FAG/FB can very simply configure an adjustment-free CD player.

Thus, the IC is suitable for CD systems for automobiles and radio-cassette players.

Features

- Single-chip CD processor with on-chip CMOS LCD driver and 4-bit microcontroller
- Operating supply voltage:
 - CD in operation: VDD = 3.0 to 3.6 V (3.3 V typ.)
 - CD stopped: VDD = 1.8 to 3.6 V (only CPU in operation)
- Supply current:
 - CD in operation: IDD = 30 mA (typ.)
 - CD stopped: $I_{DD} = 1.5 \text{ mA}$ (CD standby mode, with 16.9344-MHz crystal oscillator, CPU in operation)
 - CD stopped: IDD = 50 µA (CD standby mode, with 75-kHz crystal oscillator, CPU in operation)
- Operating temperature range: Ta = -40 to 85°C
- Package: LQFP/QFP-64 (0.5/0.65-mm pitch, 1.4 mm thick)
- E²PROM: TC94AE29FAG/FB



Weight LQFP64-P-1010-0.50: 0.32 g (typ.) QFP64-P-1212-0.65: 0.45 g (typ.)



4-bit Microcontroller

- Program memory (ROM): 16 bits × 8 Ksteps
- Data memory (RAM): 4 bits × 512 words
- Instruction execution time: 1.42 μs, 40 μs, 91.6 μs, TOSC × 3 (Every instruction consists of a single word.)
- Crystal oscillator frequency: 16.9344 MHz, 75 kHz, 32.768 kHz, CR oscillation frequency
- Stack levels: 6
- AD converter: 6 bits × 4 channels
- LCD driver: 1/4 duty, 1/2 or 1/3 bias method, 64 segments (max.)
- I/O ports: CMOS I/O ports: 26 (max.)

N-channel open-drain I/O ports (for up to 5.5 V): 3 (max.)

- Timer/counter: 8 bits (timer mode, pulse width detector and measure function)
- General-purpose counter: 20 bits, 0.1 MHz to 20 MHz, Vin = 0.2 Vpp (min.), input amplifier incorporated
- Serial interface module: 1 port 2 channel supporting 2/3-line method or UART (two input channels)
- Four buzzer types: 0.75 kHz, 1 kHz, 1.5 kHz, and 3 kHz
- Four modes: continuous, single-shot, 10 Hz intermittent, and 10 Hz intermittent at 1 Hz intervals
- Interrupts: 1 external, 3 internal (CD sub-sync, serial interface, 8-bit timer)
- Back-up mode: Four types: CD standby (CD processor stopped)

Clock stop (oscillator stopped)

Hardware wait (only crystal oscillator in operation) Software wait (CPU in intermittent operation)

• Reset function: Power-on reset circuit, supply voltage detector (detection voltage = 1.5 V typ.)

CD Processor

- · Reliable sync pattern detection, sync signal protection and interpolation
- Built-in EFM demodulator and subcode decoder
- High-correction capability using Cross Interleave Read Solomon Code (CIRC) logical equation

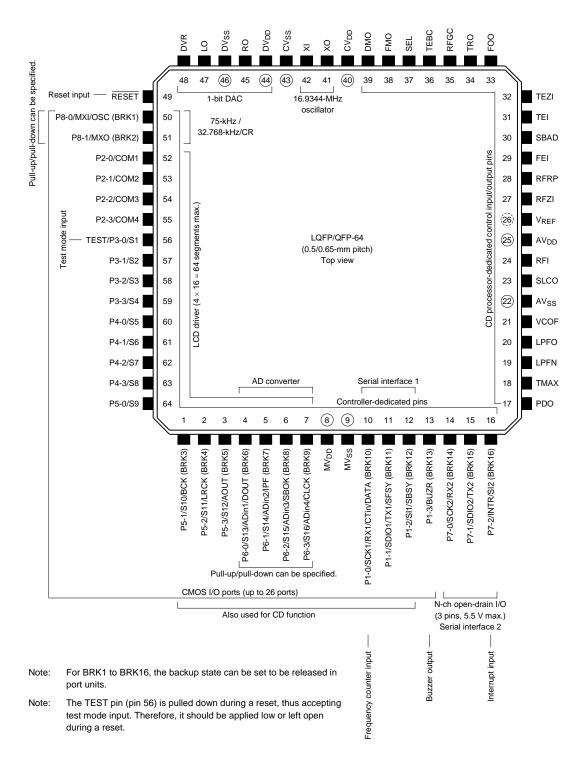
C1 correction: dual

C2 correction: quadruple

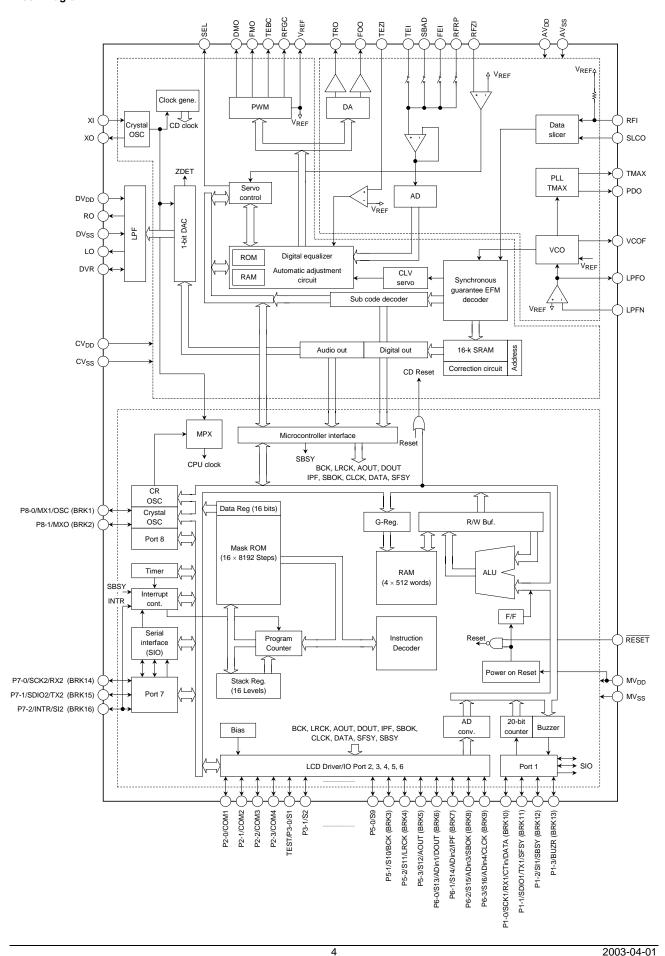
- Jitter absorption capability of ± 6 frames
- Built-in 16 KB RAM
- Built-in digital output circuit
- · Built-in L/R independent digital attenuator
- Bilingual audio output
- Audio output: 32fs, 48fs or 64fs selectable
- Subcode Q data is read-timing free and can be driven out in sync with audio data.
- Built-in data slicer and analog PLL (adjustment-free VCO used) circuit
- · Automatic adjustment of loop gain, offset, and balance at focus servo and tracking servo
- Built-in RF gain auto-adjusting circuit
- Built-in digital equalizer for phase compensation
- Supports different pickups using on-chip digital equalizer coefficient RAM.
- · Built-in focus and tracking servo control circuit
- Search control supports all modes and realizes high-speed, stable search.
- Lens kick and feed kick use speed control method.
- · Built-in AFC and APC circuits for disc motor CLV servo
- Built-in defect/shock detector
- Built-in 8 times over-sampling digital filter and 1-bit DA converter
- Built-in analog filter for 1-bit DA converter
- Built-in zero-data detection output circuit
- Supports double-speed operation.

Note: Output pins for subcode Q data and audio data have multiplexed functions for controller-dedicated pins. The function of each pin can be switched by program.

Pin Connections



Block Diagram





Pin Functions

Pin No.	Symbol	Pin Name	Function and Operation	Remarks
49	RESET	Reset input	System reset input pin for the device. A reset is applied while the RESET signal is low. When it is high, the 16.9344-MHz crystal oscillator (XI, XO) starts operating. The controller counts clock pulses from this oscillator and waits a specified standby time (approximately 50 ms) before starting the controller program from address 0. The CD processor is placed in the standby state at this time. Normally, raising the voltage on MVDD from 0 to 1.8 V or higher triggers a system reset (power-on reset) so that the RESET pin should be held at high.	MV _{DD} MV _{SS}
50	P8-0 /MXI /OSC (BRK1) P8-1 /MXO (BRK2)	I/O port 8-0 /crystal oscillator /CR oscillator I/O port 8-1 /crystal oscillator	2-bit CMOS I/O port. Input/output can be specified for each bit. When the pins are used as I/O port input, each pin can be pulled up or down by program. When backup release for clock stop mode or wait mode is enabled for the pins, a change in a pin can release the backup state. The program can set these pins to be used for a 75-kHz or 32.768-kHz dedicated crystal oscillator. The P8-0 pin can also be used for a CR oscillator. These clocks are used for the operation of the controller and peripheral devices. Upon a system reset, the 16.9344-MHz crystal oscillator (XI, XO) is selected as the clock for controller and peripheral device operation. The program can subsequently set the pins to oscillator pins and switch the clock generated from the oscillator to the controller clock. When the pins are used for an oscillator, executing the CKSTP instruction causes its oscillation to stop. (Note) When the P8-0 pin is used for a CR oscillation, the P8-1 pin can used as an I/O port pin. (Note) Backup release is enabled for both pins simultaneously. (Note) Use a crystal oscillator having a good startup characteristic. (Note) Upon a system reset, the pins are set to I/O port input. (Note) After setting the pins to oscillator pins, wait until oscillation settles before switching the controller clock.	MVDD Input instructio RIN1 MVDD MVSS (When used for I/O port) Rout2 MVDD MXI MVDD MVD

Pin No.	Symbol	Pin Name	Function and Operation	Remarks
52 53 54 55	P2-0/COM1 P2-1/COM2 P2-2/COM3 P2-3/COM4	I/O port 2 /LCD common output	24-bit CMOS I/O port and 3-bit N-channel open-drain I/O port. Input/output can be specified for each bit. When the P6-0 to P6-3 pins are used as I/O port input, each pin can be pulled up or down by program. When the P5-1 (BRK3) to P7-2 (BRK16) pins are used as I/O port input and backup release for clock stop mode or wait mode is enabled for those pins (enabled/disabled in port units), a change in any of the pins can release the backup state. The P7-0 to P7-2 pins constitute an N-channel open-drain I/O port, to which a voltage of up to 5.5 V can be applied. I/O ports 2 to 6 can be set to LCD driver output pins by program. The COM1 to COM4 pins	LCD voltage MV _{DD} MV _{DD}
56	TEST /P3-0/S1	Test input /I/O port 3-0 /LCD segment output	drive common signals to the LCD panel while the S1 to S16 pins drive segment signals. The COM1 to COM4 signals configure a matrix with the S1 to S16 signals to display up to 64 segments. When the LCDoff bit is set to 0, the COM1 to COM4 and S1 to S4 pins are collectively set to LCD output. For S5 to S16, the program can specify either I/O port or segment output individually for each pin. The LCD can be driven by the 1/4-duty, 1/2-bias method (frame frequency: 62.5 Hz) or the 1/4-duty, 1/3-bias method (frame frequency: 125 Hz). When the 1/2 bias method is set, three common output levels (MVDD, 1/2MVDD and GND) and two segment output levels (MVDD and GND) appear on the pins. When the 1/3 bias method is set, four common and segment output levels (MVDD, 1/3MVDD, 2/3MVDD and GND) appear on the pins. Upon a system reset or after clock stop mode is	LCD voltage MVDD MVDD MVDD Reset signal
57 58 59	P3-1/S2 P3-2/S3 P3-3/S4	I/O port 3 /LCD segment output	released, a non-select waveform (bias voltage) is driven and the DISP OFF bit is set to 0, after which the common signals are driven. During a system reset (RESET = low), the	LCD voltage
60 61 62 63	P4-0/S5 P4-1/S6 P4-2/S7 P4-3/S8	I/O port 4 /LCD segment output	TEST/P3-0/S1 pin is pulled down and accepts test mode input. This pin should be left open or applied low level during a reset. The P5-1 to P6-3 and P1-0 to P1-2 pins can be set to CD processor-dedicated pins on a per pin basis. The CD processor functions are as follows: (Continued on next page)	MV _{DD} Input Instruction

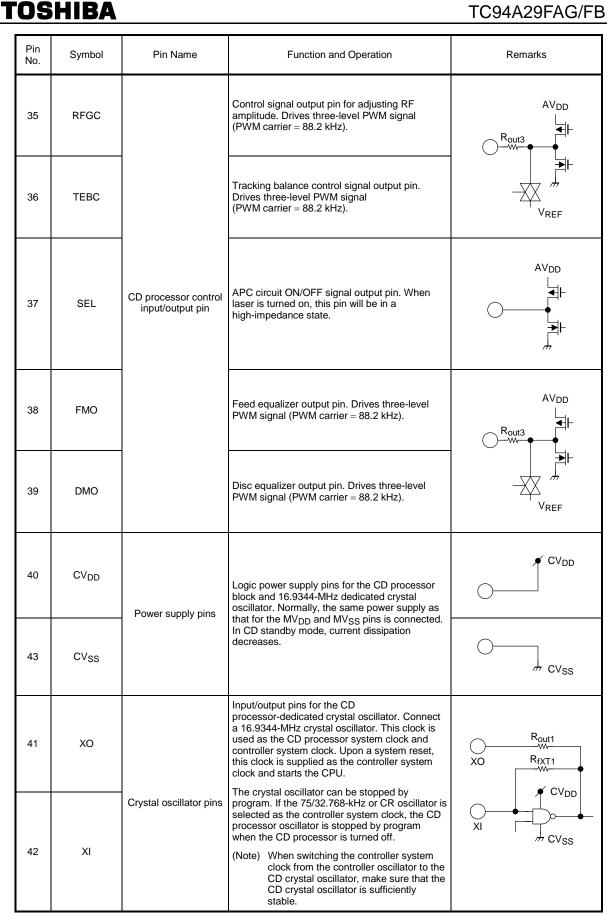


Pin No.	Symbol	Pin Name	Function and Operation	Remarks
64	P5-0/\$9	I/O port 5-0 /LCD segment output	BCK: Bit clock output pin. One of three frequencies, 32, 48 or 64 can be specified using a CD command. At normal speed: 32 f _s = 1.4112 MHz CLRCK: LR channel clock output pin. For the L channel, this pin drives a low level. For the R channel, it drives a high level. The polarity can be inverted using a CD command. At normal speed: 44.1 kHz AOUT: Audio data output pin. Either MSB first or LSB first can be specified using a CD command.	LCD voltage MV _{DD}
1 2 3	P5-1/S10 /BCK (BRK3) P5-2/S11 /LRCK (BRK4) P5-3/S12 /AOUT (BRK5)	I/O port 5 /LCD segment output /CD processor function	 DOUT: Digital data output pin. It drives data at up to double speed (complying with CP-1201). IPF: Correction flag output pin. If the AOUT output is C2 error detection/correction, a high level appears to indicate an uncorrectable symbol. (Also called C2PO) SBOK: CRCC test result output pin for subcode Q data. A high level appears when the data has passed the test. CLCK: Clock input/output pin for reading subcode P to W data. The input/output polarity can be inverted using a CD command. DATA: Subcode P to W data output pin. SFSY: Frame sync signal output pin for 	LCD voltage MV _{DD}
4 5 6	P6-0/S13 /ADin1 /DOUT (BRK6) P6-1/S14 /ADin2 /IPF (BRK7) P6-2/S15 /ADin3 /SBOK (BRK8) P6-3/S16 /ADin4 /CLCK (BRK9)	I/O port 6 /LCD segment output /CD processor function	playback. SBSY: Block sync signal output pin for subcode. When a subcode sync is detected, a high level appears at S1. The controller enables CD interrupts. When an interrupt occurs on the falling edge of the SBSY signal, the program jumps to address 2. (Note) Interrupts should not be enabled when CD processor operation is undefined. P6-0 to P6-3 pins have multiplexed functions for the on-chip 6-bit 4-channel AD converter analog input. The on-chip AD converter uses successive approximation. The conversion time is 242 μs when the 16.9344-MHz crystal oscillator is used and 7 instruction cycles (280 μs) when the 75-kHz crystal oscillator is used. The program can specify necessary pins for AD analog input on a per bit basis. The internal power supply (MV _{DD}) is used as the reference voltage. When the P6-0 to P6-3 pins are used as I/O port input, each pin can be pulled up or down by program.	AD input LCD voltage MVDD MVDD MVDD MVDD MVDD MVSS

Pin No.	Symbol	Pin Name	Function and Operation	Remarks
10	P1-0/SCK1 /RX1 /CTin /DATA (BRK10)	I/O port 1-0 /serial clock input/output 1 /serial receive data 1 /counter clock input /CD processor function	The P1-0 pin has multiplexed functions for general-purpose counter input. The input frequency is 0.1 MHz to 20 MHz. The counter incorporates an input amplifier and operates with capacitance-coupled small amplitudes. The counter is a 20-bit counter and can store 20-bit data directly in memory. The gate time can be selected from among 1 ms, 4 ms, 16 ms and 64	MV _{DD}
11	P1-1/SDIO1 /TX1 /SFSY (BRK11)	I/O port 1-1 /serial data input/output 1 /serial transmit data 1 /CD processor function	ms (when the 75-kHz crystal oscillator is used). In manual mode, the gate can be turned on and off within the specified time using instructions. The P1-0 to P1-2 and P7-0 to P7-2 pins have multiplexed functions for serial interface (SIO)	Input instruction Release enable
12	P1-2/SI1 /SBSY (BRK12)	I/O port 1-2 /serial data input 1 /CD processor function	circuit input/output pins. The SIO is a serial interface supporting 2-line and 3-line methods as well as UART. The TC94A29FAG/FB has CMOS input/output pins (SCK1/RX1, SDIO1/TX1, SI1) and N-channel	(When used for I/O port) R _{fIN}
13	P1-3/BUZR (BRK13)	I/O port 1-3 /buzzer output	open-drain (supporting up to 5.5 V) input/output pins (SCK2/RX2, SDIO2/TX2, SI2). One of the two sets of pins can be selected as serial interface. The serial interface circuit supports various options, including the number of the clock edge to be used, the serial clock input/output, and the clock frequency. These options facilitate controlling the LSI and communications between the controllers. When SIO interrupts are enabled, an interrupt is generated as soon as execution of the SIO	MVDD CTin MVSS (When P1-0 is used for general-purpose counter)
14	P7-0/SCK2 /RX2 (BRK14)	I/O port 7-0 /serial clock input/output 2 /serial receive data 2	completes, causing the program to jump to address 4. The P1-3 pin has multiplexed functions for a buzzer output pin. One of four frequencies within the range from 0.75 kHz, 1 kHz, 1.5 kHz	
15	P7-1/SDIO2 /TX2 (BRK15)	I/O port 7-1 /serial data input/output 2 /serial transmit data 2	and 3 kHz can be selected for buzzer output (when the 75-kHz clock is used). The buzzer is driven at the selected frequency in one of four modes: continuous, single-shot, 10-Hz	
16	P7-2/INTR /SI2 (BRK16)	I/O port 7-2 /interrupt input /serial data input 2	intermittent, and 10-Hz intermittent at 1-Hz intervals. The P7-2 pin has multiplexed functions for an external interrupt input pin. When interrupts are enabled and a pulse of 1.65 μs to 4.96 μs or more (13.3 μs to 40 μs when the 75-kHz clock is used) is applied to this pin, an interrupt is generated and the program jumps to address 1. The input logic and rising/falling edge can be selected for interrupt inputs. This input can be applied as the clock gate signal to the internal 8-bit timer/counter, which allows input pulse width to be detected and measured. (Note) Backup release is enabled or disabled in port units. (Note) Upon a system reset, the pins are set to I/O port input. (Note) When the 32.768-kHz crystal oscillator or the CR oscillator is used, the general-purpose counter is used as a timer.	Input instruction Release enable

Pin No.	Symbol	Pin Name	Function and Operation	Remarks
8	M∨ _{DD}	- Power supply pins for controller block	Power supply pins for the controller block. Normally, $V_{DD}=3.0$ to 3.6 V. When only the CPU operates (when the 75-kHz/32.768-kHz oscillator is used), it can operate at $V_{DD}=1.8$ to 3.6 V. In the backup state (when the CKSTP instruction is executed), current dissipation decreases (10 μ A or below), allowing the power	MV _{DD}
9	MVss		supply voltage to be reduced to 1.0 V. Raising the voltage on MVDD pin from 0 V to 1.8 V or higher triggers a system reset, causing the program to start from address 0 (power-on reset). (Note) At power-on reset operation, allow 1 ms to 50 ms while the device power supply voltage rises. (Note) The backup current is the total of currents for CVDD, MVDD and DVDD.	MVss
17	PDO		Output pin for a phase error signal between the EFM and PLCK signals. Drives one of four values: AV _{DD} , Hi-Z, V _{REF} , AV _{SS}	AV _{DD} R _{out4} AV _{SS} V _{REF}
18	TMAX	CD processor control input/output pin	TMAX detection result output pin. Longer than specified cycle: Drives a high level (AV _{DD}) Shorter than specified cycle: Drives a low level (AV _{SS}) Within specified cycle: Hi-Z	AV _{DD}
19	LPFN		Inverted input pin for PLL low-pass filter amplifier.	AV _{DD}
20	LPFO		Output pin for PLL low-pass filter amplifier.	LPFO C
21	VCOF		VCO filter pin	VREF VCO
22	AV _{SS}		Ground pin for analog block	_

Pin No.	Symbol	Pin Name	Function and Operation	Remarks
23	SLCO		DAC output pin for generating data slice level.	Z _{in1} W V _{REF} AV _{DD}
24	RFI		RF signal input pin. The value of Zin1 can be selected using a CD command.	SLCO DAC
25	AV _{DD}		Power supply pin for analog block. Normally, V _{DD} = 3.0 to 3.6 V. In CD standby mode, turn this power supply off.	_
26	V _{REF}		Analog reference voltage pin. Normally, a voltage of 1/2 AV $_{DD}$ is supplied (when $V_{DD}=3.3~V, V_{REF}=1.65~V$).	_
27	RFZI		RFRP zero-cross signal input pin	RFZI Z_{in2}
28	RFRP	CD processor control input/output pin	RF ripple signal input pin	AV _{DD}
29	FEI		Focus error signal input pin	FEI
30	SBAD		Sunbeam addition signal input pin	SBAD
31	TEI		Tracking error input pin. The pin is read when tracking servo is turned on.	TEI
32	TEZI		Tracking error/zero-cross signal input pin	TEZI Z_{in2} V_{REF} $V_{$
33	FOO		Focus equalizer output pin	AV _{DD} A V _{DD}
34	TRO		Tracking equalizer output pin	AVss





Pin No.	Symbol	Pin Name	Function and Operation	Remarks
44	DV _{DD}		DA converter block power supply pin The TC94A39FAG/FB consumes less current in CD standby mode.	DV _{DD}
45	RO		R-channel data forward rotation output pin	DVR www.
46	DV _{SS}	Audio DAC output	DA converter block ground pin	RO/LO P
47	LO		L-channel data forward rotation output pin	DVss
48	DVR		Reference voltage pin	Vss



Maximum Ratings (Ta = 25°C, $CV_{DD} = DV_{DD} = AV_{DD} = MV_{DD}$)

Characteri	stic	Symbol	Rating	Units
Supply voltage		V_{DD}	-0.3 to 4.0	V
	CV _{DD} pin	V _{IN1}	-0.3 to CV _{DD} + 0.3	
	AV _{DD} pin	V _{IN2}	-0.3 to AV _{DD} + 0.3	
Input voltage (Note 1)	DV _{DD} pin	V _{IN3}	-0.3 to DV _{DD} + 0.3	V
	MV _{DD} pin	V_{IN4}	-0.3 to $MV_{DD} + 0.3$	
		V _{IN5}	−0.3 to 6.0	
Power dissipation	TC94A29FAG	PD	400	mW
Fower dissipation	TC94A29FB	۲۵	500	IIIVV
Operating temperature		T _{opr}	−40 to 85	°C
Storage temperature		T _{stg}	−65 to 150	°C

Note 1: V_{IN1}; Pins 41 and 42

V_{IN2}; Pins 17 to 39 (excluding power supply pins)

V_{IN3}; Pins 45, 47 and 48

V_{IN4}; Pins 1 to 13 and 49 to 64 (excluding power supply pins)

V_{IN5}; Pins 14, 15 and 16



Electrical Characteristics (Ta = 25°C, $CV_{DD} = MV_{DD} = DV_{DD} = AV_{DD} = 3.3 \text{ V}$, $V_{REF} = 1.65 \text{ V}$ unless otherwise stated)

Parameter	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Units
	V _{DD1}		CPU and CD in operation $MV_{DD} = CV_{DD} \geqq DV_{DD} = AV_{DD} \tag{Note 4}$	3.0	~	3.6	
Operating supply voltage range	V _{DD2}	_	CPU in operation (CD standby, 16.9344-MHz crystal oscillator/CR oscillator used) (Note 4)	3.0	~	3.6	V
	V _{DD3}		Only CPU in operation (CD standby, 75-kHz/32.768-kHz crystal oscillator used) (Note 5)	1.8	~	3.6	
Memory hold voltage range	MV _{HD}	_	Crystal oscillator stopped (CKSTP instruction executed) (Note 4)	1.0	~	3.6	V
	I _{DD1}		CPU and CD in operation (XI = 16.9344-MHz crystal oscillator used)		30	50	mA.
	I _{DD2}		Only CPU in operation (XI = 16.9344-MHz crystal oscillator used)		1.5	_	IIIA
Operating power supply current	I _{DD3}	_	CPU in operation (MXI = 75-kHz crystal oscillator connected)		50	100	μА
(Note 2)	I _{DD4}		CPU in operation (OSC = 0.5-MHz oscillation)	_	2.0	_	mA
	I _{DD5}		Standby mode (only crystal oscillator in operation, MXI = 75 kHz)		40	80	μΑ
Memory hold current	MI _{HD}	_	(CV _{DD} /MV _{DD} /AV _{DD} /DV _{DD}) Crystal oscillator stopped (CKSTP instruction executed)	_	0.1	10	μА
	f _{MXT}		(MXI-MXO) Crystal oscillator selected (Note 3) (Note 5)	30	~	100	kHz
Oscillation frequency	f _{XT}	—	(XI-XO) (Note 4)		16.9344	_	MHz
	fosc		(OSC) CR oscillator selected	0.01	~	0.75	IVITZ
Oscillating frequency error	Δf _{OSC}	_	(OSC) CR oscillator selected		_	15	%
Crystal oscillator start time	t _{st}	_	(MXI-MXO) Crystal oscillator f _{mxt} = 75 kHz/32.768 kHz	_	_	1.0	S
Crystal oscillator amplifier	R _{fXT1}		(XI-XO)	0.5	1.0	2.0	MO
feedback resistance	R _{fXT2}		(MXI-MXO)	_	16	_	ΜΩ
Crystal oscillator output	R _{out1}		(XO)	0.25	0.5	1.0	kΩ
resistance	R _{out2}		(MXO)	50	100	200	N3.2
Dropout voltage detect voltage	V _{DET}	_	(MV _{DD}) Dropout voltage detector enabled	1.4	1.5	1.6	V
Dropout voltage detector operating current	I _{DD} -V _D	_	(INIVIDI) Diopout voltage detector enabled	_	100		μА

- Note 2: The operating power supply current includes the total current through all CV_{DD} , MV_{DD} , DV_{DD} and AV_{DD} power supply pins.
- Note 3: Design and specify constants according to the crystal oscillator to be connected.
- Note 4: The values are guaranteed when $CV_{DD} = MV_{DD} = DV_{DD} = AV_{DD} = 3.0$ to 3.6 V, Ta = -40 to 85°C.
- Note 5: The values are guaranteed when $CV_{DD} = MV_{DD} = DV_{DD} = AV_{DD} = 1.8$ to 3.6 V, Ta = -30 to $75^{\circ}C$.



General-purpose counter (CTin)

Parameter	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Units
Frequency range	f _{CT}	_	$V_{\mbox{\footnotesize{IN}}} = 0.2 \ V_{\mbox{\footnotesize{P-P}}} \eqno(\mbox{Note 4})$	0.1	_	20	MHz
Input amplitude range	V _C T	_	(Note 4)	0.2	_	2.0	V _{P-P}
Operating power supply current	I _{DD-CT}	_	General-purpose counter operating current, $f_{\text{in}} = 20 \text{ MHz}$	_	0.7	1	mA
Input amplifier feedback resistance	R _{fIN}	_	(CTin)	200	350	1000	kΩ

Note 4: The values are guaranteed when $CV_{DD} = MV_{DD} = DV_{DD} = AV_{DD} = 3.0$ to 3.6 V, Ta = -40 to $85^{\circ}C$.

LCD common and segment outputs (COM1 to COM4, S1 to S16)

Parameter		Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Units
Output current	High level	I _{OH1}		V _{OH} = 2.9 V (LCD output)	_	-300	_	^
	Low level	I _{OL1}		V _{OL} = 0.4 V (LCD output)		450		μА
	1/2 level	V _{BS2}		No load (common output, 1/2 bias method)	2.3	2.5	2.7	
Bias current	1/3 level	V _{BS1}	_	No load (LCD output, 1/3 bias method)	1.47	1.67	1.87	V
	2/3 level	V _{BS3}		No load (LCD output, 1/3 bias method)	3.13	3.33	3.53	
LCD operating power supply current		I _{DD-} LCD	_	LCD driver operating current		50		μА

I/O ports (P1-0 to P6-3, P8-0, P8-1, P7-0 to P7-3)

Parame	eter	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Units
	High level	I _{OH2}		V _{OH} = 2.9 V (P1-0~P6-3, P8-0, P8-1)	-1.0	-2.0	_	
Output current	Low level	I _{OL2}] - [V _{OL} = 0.4 V (P1-0~P6-3, P8-0, P8-1)	1.0	2.0	_	mA
	LOW level	I _{OL3}		V _{OL} = 0.4 V (P7-0 to P7-3)	5	15	_	
Input leakage cu	Input leakage current		_	$V_{IH} = 3.3 \text{ V},$ $V_{IL} = 0 \text{ V} \text{ (P1-0 to P6-3, P8-0, P8-1)}$			±1.0	μА
				$V_{IH} = 5.5 \text{ V}, V_{IL} = 0 \text{ V} \text{ (P7-0 to P7-3)}$	_	_	±1.0	
Input voltage	High level	V _{IH}		_	$\begin{array}{c} V_{DD} \times \\ 0.8 \end{array}$	~	MV_{DD}	V
Input voltage	Low level	V _{IL}		_	0	~	$\begin{array}{c} \text{MV}_{DD} \\ \times \ 0.2 \end{array}$	V
Input pull-up/down resistance		R _{IN1}	_	(P6-0 to P6-3, P8-0, P8-1) Pull-down/up specified	25	50	120	kΩ
		R _{IN2}		(P3-0) Test input pulled down	_	10	_	

AD converter (ADin1 to ADin4)

Parameter	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Units
Analog input voltage range	V_{AD}	_	ADin1 to ADin4	0	~	MV_{DD}	V
Resolution	V _{RES}	_		_	6	_	bit
Total conversion error	_	_	$MV_{DD} = 1.8 \sim 3.6 V$, $Ta = -30 \sim 75 ^{\circ}C$ (Note 6)	_	_	±2.0	LSB
lotal conversion error			$MV_{DD} = 2.0 \sim 3.6 V$, $Ta = -40 \sim 85 °C$ (Note 6)	_	_	±1.0	
Analog input leakage current	IΠ	_	$V_{IH} = 3.3 \ V, \ V_{IL} = 0 \ V$ (ADin1 to ADin4)	_	_	±1.0	μΑ

Note 6: The values are guaranteed when $CV_{DD} = DV_{DD} = AV_{DD} = 3.0$ to 3.6 V.



PDO, TMAX, RFGC, TEBC, FMO, DMO, TRO, FOO, and SEL output

Parame	eter	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Units
Output current	High level	I _{OH6}		V _{OH} = 2.9 V (SEL, TMAX)	-2.0	_	_	mA
Output current	Low level	I _{OL4}		V _{OL} = 0.4 V (SEL, TMAX)	2.0	_	_	ША
Output resistance	Output resistance			(RFGC, TEBC, FMO, DMO, TRO, FOO)	_	3.0	_	kΩ
Output resistance		R _{out4}		(PDO)	_	5.0	_	KS2
V _{REF} output ON	resistance	R _{on}	_	(RFGC, TEBC, FMO, DMO, PDO)	_	_	500	Ω

Transfer delay time (BCK, LRCK, AOUT, DOUT, IPF, SBOK, CLCK, DATA, SFSY, SBSY)

Paramo	eter	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Units
Transfer delay	High level	t _{pLH}		_	_	10		ns
time	Low level	t _{pHL}		_	_	10	_	115

CD processor AD conversion block (FEI, TEI, RFRP, SBAD)

Parameter	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Units
Resolution	_	_	(FEI, TEI, RFRP, SBAD)	_	8	_	bit
Sampling frequency	_		(FEI, TEI, RFRP)	_	176.4	_	kHz
Sampling frequency			(SBAD)	_	88.2	_	KIIZ
Conversion input range		_	AV _{DD} = 3.3 V (FEI, TEI, RFRP, SBAD)	0.15 × AV _{DD}	_	$\begin{array}{c} 0.85 \times \\ \text{AV}_{DD} \end{array}$	V

CD processor DA conversion block (focus tracking system)

Parameter	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Units
Number of bits	_	_	(FOO, TRO)	_	5	_	bit
Sampling frequency	_	_	(FOO, TRO)	_	2.8	_	MHz
Conversion output range	_	_	AV _{DD} = 3.3 V (FOO, TRO)	AVSS	_	AV_{DD}	V

CD processor PLL/VCO block

Parameter	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Units
Input/output signal range	_	_	(LPFN, LPFO)	AVSS	_	AV_{DD}	V
Frequency characteristic	_	_	(LPFN-LPFO) -3dB point (Gain = 1)	_	8	_	MHz
Oscillation center frequency	_	_	LPFO = V _{REF}	_	34	_	MHz
Frequency variable range			[VCOGSL] bit = Low	-30	_	+30	%
	_		[VCOGSL] bit = High	-40	_	+40	/0

CD processor comparator (TEZI, RFZI)

Parameter	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Units
Input range	_	_	(TEZI, RFZI)	AVSS	_	AV_{DD}	V
Hysteresis voltage	_	_	(TEZI, RFZI) V _{REF} reference	-50	_	+50	mV
Input resistance	Z _{in2}	_	(TEZI, RFZI)	_	10	_	kΩ

CD processor data slicer (RFI/SLCO)

Parameter	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Units
Input amplitude	_	_	(RFI) V _{REF} reference	0.6	1.2	2.0	V _{P-P}
Input resistance	Z _{in1}	_	(RFI) Set resistance by CD command	_	20	_	kΩ
				_	10	_	K22
DAC resolution	_	_	(SLCO) R-2R DAC	_	6	_	bit
DAC output conversion range	_	_	(SLCO) R-2R DAC	0.75 × V _{REF}	_	1.25 × V _{REF}	V
DAC output impedance	_	_	(SLCO) R-2R DAC	_	2.5	_	kΩ

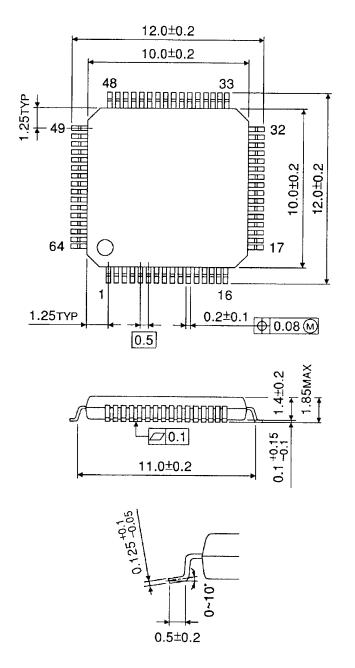
1-bit DA converter

Parameter	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Units
Total harmony distortion	THD + N	_	1-kHz sine wave, full-scale input	_	-85	-77	dB
0/11 /	S/N (1)		Internal Zero detect = OFF	85	91	_	dB
S/N ratio	S/N (2)	_	Internal Zero detect = ON	95	100	_	иБ
Dynamic range	DR	_	1-kHz sine wave, input reduction of -60dB	83	90	_	dB
Crosstalk	CT	_	1-kHz sine wave, full-scale input	_	-90	-83	dB
Analog output level	DACout	_	1-kHz sine wave, full-scale input	790	825	860	mVrms

Package Dimensions

LQFP64-P-1010-0.50

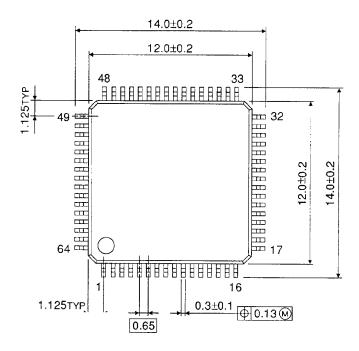
Unit: mm

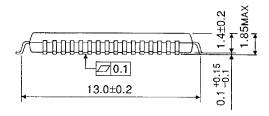


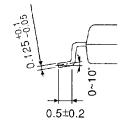
Weight: 0.32 g (typ.)

Package Dimensions

QFP64-P-1212-0.65 Unit: mm







Weight: 0.45 g (typ.)

RESTRICTIONS ON PRODUCT USE

000707EBA

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
 In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The products described in this document are subject to the foreign exchange and foreign trade laws.
- The information contained herein is presented only as a guide for the applications of our products. No
 responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other
 rights of the third parties which may result from its use. No license is granted by implication or otherwise under
 any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.